Realization of a superconducting atom chip

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We have trapped rubidium atoms in the magnetic eld produced by a superconducting atom chip operated at liquid Helium temperatures. Up to $8.2 \cdot 10^5$ atoms are held in a Io e-Pritchard trap at a distance of 440 m from the chip surface, with a temperature of 40 K. The trap lifetime reaches 115 s at low atomic densities. These results open the way to the exploration of atom {surface interactions and coherent atomic transport in a superconducting environment, whose properties are radically dierent from normal metals at room temperature.

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In atom chip experiments, cold atoms are trapped in the magnetic eld gradients created by micron-sized current carrying wires [1] or ferrom agnetic structures [2]. The design of the magnetic potential is thus very exible, allowing for a precise manipulation of the external degrees of freedom of the atom ic sample. In this context, the operation of a conveyor belt [3] or of an atom ic beam – splitter [4] have been demonstrated. These devices are particularly interesting for preparing degenerate bosonic or ferm ionic quantum gases [5, 6].

Atom chips have a wealth of potential applications. They lead to the realization of compact atom ic clocks [7], which are a key element for communication and positioning. Integrated atom interferometers [8] could be used as compact inertial sensors. More generally, atom chips open the possibility to bring well-controlled atom ic samples close to \conventional" micro-or optoelectronic systems, an important step for quantum information processing and communication.

These objectives require the preservation of atom ic coherence in the vicinity of the chip surface. At room temperature, as is the case in all atom chips experiments so far, various noise sources can jeopardize coherent atom ic manipulations. Fluctuating currents of them all origin (Nyquist noise) in a metallic substrate lead to uctuating magnetic elds at the trap center. These eld uctuations can induce spurious transitions towards untrapped atom ic states and are thus a potentially harm ful source of atom ic losses [9].

The eld noise spectrum in the vicinity of a superconductor is expected to be drastically dierent from that of a normal metal at room temperature. A coordingly, the trap lifetime should increase signicantly [10], with interesting potentialities for coherent atomic manipulations. Moreover one bene to from an extremely good vacuum because of cryogenic pumping, as it has already been demonstrated for magnetic traps with centimeter-size coils [11].

We report here the operation of a superconducting atom chip. This experiment opens the way to studies of the interactions of cold atoms with superconducting surfaces and currents. In the longer term, we plan to use such a device to prepare cold Rydberg atoms and hold them for long times in a coherence-preserving electric trap [12]. These atoms, shielded from room temperature blackbody radiation, could be employed for quantum information and fundamental studies on atom {surface and atom {atom interactions in dense Rydberg gases [13].

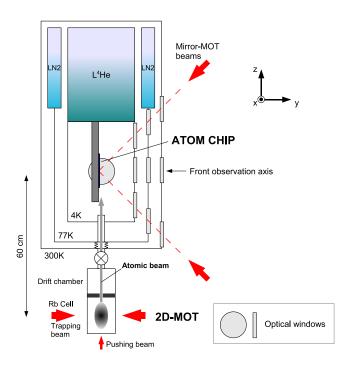


FIG. 1: (Color online) Scheme of the experiment. Laser beams along the x direction are not represented

The atom s are cooled and trapped in a sequential process, taking place in the set-up sketched in Fig. 1. Rubidium atom s (87 Rb) from a room temperature vapor are trapped and cooled in a 2D-m agneto optical trap (MOT) producing an intense slow atom ic beam which propagates upwards towards the experimental chamber

in the cryostat. The beam is recaptured in front of the chip in a mirror-MOT using centim eter-sized superconducting coils [14]. The atom ic sample is then transferred into a tighter mirror-MOT whose eld is produced by on-chip wires and, nally, brought into a Io e-Pritchard magnetic trap.

The 2D-MOT UHV chamber at room-temperature is made up of two separate parts (Rb cell and drift cham ber) connected together by a 10 mm tunnel with a small 0.8 mm diam eter allowing for di erential pum ping. The pressure in the cell is limited by the Rb background pressure to 10 8 m bar whereas the drift chamber is evacuated to a few 10 10 m bar. A tom s are trapped in the Rb cell along the horizontal x and y directions by counterpropagating laser beam s (30 m W per beam, waist 40 m m along z and 20 mm along x and y, detuned by 2:7 from the closed $5S_{1=2}$; F = 2 to $5P_{3=2}$; F = 3 transition). A repumping laser, tuned to the F = 1 to F = 2 transition, is superimposed with the trapping beams. The 2D quadrupolar magnetic eld gradient in the xy plane is 10 G auss/cm . A vertical laser beam along z (intensity 6 m W /cm²) extracts the atoms from the 2D-MOT and pushes them towards the cryostat. When they get out of the horizontal repumping beams, a few om above the 2D \rightarrow M O T, they are pum ped into the F = 1 dark state and are no longer pushed. The total atom ic ux in the drift cham ber is 1:5 10 atom s/s. The velocity distribution spreads between 10 and 20 m/s and can be tuned by adjusting the power of the pushing beam. The atom ic beam divergence (6 m rad) is determined by the diameter of the tunnel connecting the two chambers which is 18 cm above the 2D -M O T. The resulting beam diameter in front of the chip (60 cm above the 2D -MOT) is 3.5 mm, smaller than the distance to the chip surface (5 mm). A direct contam ination of the chip by the atom ic beam is thus avoided.

The beam from the 2D-MOT enters a ⁴He cryostat through a 10 mm diam eter tube made of Nylon and stainless steel bellows with low them al conductivity. The tube couples into an inner experim ental cell cooled down to 42 K which has nearly no connection with the insulation vacuum of the cryostat (8 108 mbar), in order to bene t from the extremely e cient cryogenic pumping by its cold surfaces. The optical view ports have a diam eter of 60 mm and are carefully mounted in order to reduce the stress due to pressure and thermal contractions. M oreover the cold windows are made of SF 57 glass, which has a particularly low stress-induced birefringence [15]. The total measured phase shift between orthogonal polarizations for a laser beam crossing the whole setup is below 0.3 rad (95% of the power remains in the desired polarization).

In the inner experimental cell, an ensemble of centimeter-sized superconducting coils mounted around the chip creates a uniform bias eld along any direction. Atoms from the low velocity beam are recap-

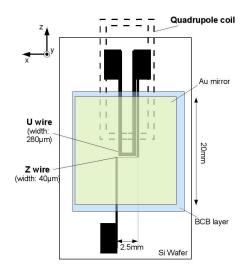


FIG. 2: (Color online) Layout of the atom chip. Black lines correspond to Nb wires. The dashed lines show the relative position of the \quadrupole" coil placed 1.5 mm behind the chip surface.

tured in a mirror-MOT in front of the chip re ecting surface [14]. Two counter-propagating laser beams are form ing a 45 deg angle with the chip surface in the yz plane and two others are propagating in opposite directions along the x axis (see Fig. 1). All beam s, brought to the experiment by polarization-maintaining bers, have a 5 mm waist and a power of 8.5 mW . A ber-coupled repumping beam (600 W) is also sent along the x direction. The quadrupole magnetic eld is obtained by an elongated 10 mm 28 mm rectangular superconducting coil placed 1.5 mm behind the chip (19 turns of N iom ax Nb-Tiwire). It produces near its bottom end the same eld as a U-shaped current distribution (see Fig. 2). Combined with a nearly uniform bias eld B_z along z, it creates a quadrupole eld over a spatial extension of a few mm [14], well adapted for an e cient capture of the atoms from the slow beam. The current in the rectangular \quadrupole" ∞ il, I_0 , is 1.77 A . and the bias eld, B_z , is 3.1 G auss.

Observations of the trapped cloud are carried out either by in aging the atom is unorescence in the MOT beams or by measuring the absorption of a resonant probe beam. In both cases, the in age is formed on a cooled CCD camera by lenses located outside the cryostat. The observation direction is either normal to the chip surface (\front" observation, along y) or along an axismaking an angle of 11 deg with respect to x (\side" observation). In the latter case, we observe both the direct in age of the cloud and its rejection on the chip. We can thus determine precisely the distance of the cloud from the surface. In a 5 s time interval, we load 5 10 atoms into the mirror-MOT at 2.1 mm from the surface. The cloud has a diameter of 2 mm and its temperature, measured by time of light, is about 300 K.

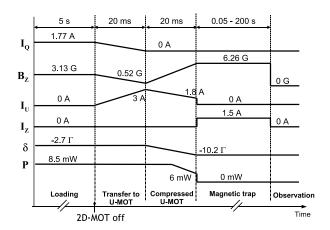


FIG. 3: Timing of the experiment. I_Q : current in the quadrupole coil, B_z : bias eld along z direction, I_U : current in the U wire, I_Z : current in the Z wire, : trapping beam detuning, P: trapping beam power.

Ouratom chip (see Fig. 2) is made on a 65 mm 30 mm silicon wafer (thickness 360 m) with a 500 nm insulating oxidized layer. It is coated by a 900 nm thick layer of Nb by cathodic plasm a sputtering. A \U-wire" (width 280 m) is used for the on-chip m irror-MOT, and a \Z wire" (width 40 m) for the magnetic Io e-Pritchard trap. The wires and contact pads are produced by standard optical lithography with a soft laser-printed mask followed by reactive ion etching. The resulting wire edge precision is about 5 m. It will be considerably improved in the future using e-beam lithography for critical areas. N iobium and silicon being bad optical re ectors, the central part of the chip is coated by a 200 nm thick layer of gold (obtained by evaporation) on a 1.5 m planarization and insulating layer of BCB (Dow chemicals, Ref. XU35133). The wafer is glued with silver lacquer and mechanically clamped on a copper plate (thickness 1 mm), in them alcontact with the 42 K bath. This plate is cut in many places in order to reduce the e ect of eddy currents and hence allow for a fast switching of the magnetic elds. The current is fed in the chip structures through Nb-TiNiomax wires soldered by a superconducting alloy [16] on the contact pads. The critical current for the U-w ire circuit is above 5 A. For the Z-w ire, the transition to norm al state occurs at 1.94(1) A without laser light. In the presence of the trapping beam s, this critical current is reduced to 1.71(1) A by the local heating due to losses in the gold m irror.

The complete timing for a trapping sequence is shown on Fig. 3. The mirror-MOT loading lasts 5 s. The 2D-MOT lasers are switched on 100 m s before the end of the loading, allowing the slowest atom s to reach the mirror-MOT. The trapped atom s are then transferred in 20 m s into the on-chip mirror-MOT, whose magnetic eld is produced by the U-wire and the uniform bias (the laser parameters are left unchanged). We decrease the current

 $\rm I_{\rm O}$ linearly from 1.77 A down to 0 A, increase simultaneously the U-wire current $\rm I_{\rm U}$ up to 3 A, and reduce the bias eld $\rm B_z$ down to 0.52 G auss. These parameters optim ize the \m ode m atching" between the two m irror-MOTs. We obtain a transfer eciency of 85% and the atom ic cloud is nally at 1.8 mm from the chip surface.

In the next step, lasting also 20 ms, we bring the sam ple at a distance of 460 m from the chip surface, corresponding to nal values of Bz and Iu of 6.26 Gauss and 1.8 A respectively. As a result, the quadrupole magnetic eld gradient increases from 5.8 Gauss/cm to 500 G auss/cm and the atom ic cloud is compressed. In order to reduce atom losses during the compression and to cooldown the sam ple, the red-shift of the trapping beam s to 10:2 and their power P is is increased from 2:7 reduced from 8.5 to 6 m W . At the end of the process, the sam ple contains 1:2 10 atom sat a tem perature of 80 K. Its dim ensions are 380 m along the y and z directions and 1200 m along x. We note that this compression stage brings the atom's closer to the chip than typical atom -chip experim ents at room tem perature. This is because of the limited critical current in the Z-wire which prevents us from performing an e cient transfer from the m irror-MOT to the magnetic trap at atom (chip distances larger than 500 m.

The transfer to the Io e-Pritchard trap is nally realized by switching o rapidly all the laser beam sin At the same time we cut I_U in 100 s and set I_Z at a value of $1.5 \, \text{A}$ (100 s rise time) The bias eld B_z remains constant during this operation. We can additionally switch on an homogeneous bias eld along the + x direction. It allow sus to control both the value of the magnetic eld as well as its gradient in the vicinity of the trap center, two important parameters determining Majorana losses. The magnetic trap is activated for a minimum tim e of 50 m s in order to let the hottest untrapped atom s escape. All the magnetic elds are then switched o and an absorption im age is taken. Figure 4(a) and (b) present front and side absorption im ages for $B_x = 0$ G auss. The total atom number is 82 10, with a distance to the chip surface of 440 m and a cloud tem perature of 40 K. The transfer e ciency from the compressed on chip mirror-MOT is thus 7%. It could be noticeably increased by adding a m olasses cooling and optical pum ping stage before the naltransfer in the magnetic trap. This requires however a fast switching of the bias eld Bz which is im possible for the m om ent because of the large inductance of the bias coils. High-voltage fast-switching power supplies will make it possible.

Figure 4(c) shows the number of atoms in the trap as a function of time with $B_x=2:75\,\mathrm{G}$ auss. It displays a double exponential decay. At the beginning, atom losses are fast (lifetime $_1=5:7\,(9)$ s). We interpret this as an evaporation process, in which the hottest atoms of the sample escape the trap and stick to the chip surface [17]. As a conmation, successive time of light measurements

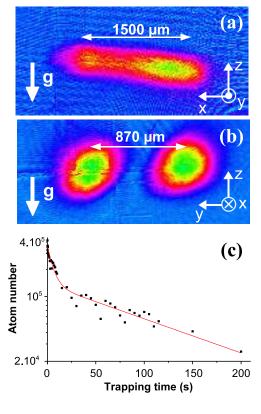


FIG. 4: (Color online) Absorption im ages of the atom ic cloud after 50 ms in the Io e-P ritchard trap with B $_{\rm X}=0$ G auss: (a) from the front and (b) from the side (direct im age and its rejection in the chip). The glarrows indicate the direction of gravity. The cloud longitudinal and transverse dimensions are 1500 m and 156 m respectively. The distance from the surface is 430 m. (c) Number of atoms in the trap with B $_{\rm X}=2.75$ G auss (log scale) as a function of time. The solid line is a bi-exponential twith characteristic times $_1=5.7\,(9)$ s and $_2=115\,(35)$ s.

during the rst 10 s show an exponential decrease of the cloud temperature from 40 K down to 20 K with a characteristic time of 32 1:3 s. At long times, above 20 s, about 25 % of the atom s are still trapped. The losses then become dram atically small (lifetime $_2 = 115(35)$ s). This long lifetime corresponds to an extremely good vacuum in the experim ental cham ber resulting from the e cient cryogenic pum ping by the cold surfaces. By assum ing that the vacuum is limited by He residual pressure with a Rb-He scattering cross-section of 100 A² [18] we infer a pressure of about 3 10¹¹ m bar. This lifetime is large enough to perform evaporative cooling for the production of a BEC [5]. We also observe that a smaller Bx bias results in a larger initial number of atoms (deeper trap) but reduces the value of 2, probably because of Majorana losses. For $B_x = 0$ G auss we obtained $_2 = 5$ (2) s.

In conclusion, our results dem on strate the feasibility of superconducting atom chip traps. We have obtained very long trapping time, in the minute range. The number of trapped atoms is su cient for reaching Bose-E instein

condensation, a short-term objective of this experiment. A signicant increase of the atom number is expected after straightforward improvements. This will allow us to study coherent atom ic manipulations in the vicinity of a superconducting environment. In particular we plan to move the cloud away from the initial trapping region towards another part of the chip where the atom ic sample will be held in front of a type I or type II superconducting surface. The trapping lifetime or the coherent transport of a BEC sample over these surfaces will be of particular interest.

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